

(PTO-1449)

SERIAL NO.

10781788

APPLICANT
Takefumi YOSHIKAWA

FILING DATE
February 20, 2004

GROUP 2819

U.S. PATENT DOCUMENTS

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FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Codes-Number + Kind Codes (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear	Translation	
						Yes	No
		JP 11-88312	03/30/1999	NEC CORP.		JAPAN (w/English Abstract)	
		JP 2000-67577 A	03/03/2000	MITSUBISHI ELECTRIC CORP.		JAPAN (w/English Abstract)	
		JP 2002-300143	10/11/2002	MATSUSHITA ELECTRIC CO LTD.		JAPAN (w/English Abstract)	

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	

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SHEET 1 OF 1

INFORMATION DISCLOSURE
CITATION IN AN
APPLICATIONATTY. DOCKET NO.
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Takefumi YOSHIKAWAFILING DATE
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U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code(s) (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
/LN/		US 2003/0031133 A1	02/13/2003	Momtaz	
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						Yes	No
Lb Lh		JP 11-88312	03/30/1998	NEC CORP.		JAPAN (w/English Abstract)	
		JP 2000-47577 A	03/03/2000	MITSUBISHI ELECTRIC CORP.		JAPAN (w/English Abstract)	
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